

SANYO Semiconductors DATA SHEET

2SC4390 — NPN Epitaxial Planar Silicon Transistor High hFE, AF Amplifier Applications

Features

- · Adoption of MBIT process.
- · High DC current gain (hFE=800 to 3200).
- Large current capacity (IC=2A).
- · Low collector-to-emitter saturation voltage (VCE(sat)≤0.3V).
- · High VEBO (VEBO≥15V).

Specifications

Absolute Maximum Ratings at Ta=25°C

| Parameter | Symbol | Conditions | Ratings | Unit |
|------------------------------|--------|---|-------------|------|
| Collector-to-Base Voltage | VCBO | | 20 | V |
| Collector-to-Emitter Voltage | VCEO | | 10 | V |
| Emitter-to-Base Voltage | VEBO | | 15 | V |
| Collector Current | IC | | 2 | Α |
| Collector Current (Pulse) | ICP | | 4 | А |
| Base Current | IB | | 0.4 | Α |
| Collector Dissipation | - | | 500 | mW |
| | PC | Mounted on a ceramic board (250mm²×0.8mm) | 1.3 | W |
| Junction Temperature | Tj | | 150 | °C |
| Storage Temperature | Tstg | | -55 to +150 | °C |

Electrical Characteristics at Ta=25°C

| Parameter | Symbol | Conditions | Ratings | | | Unit |
|--------------------------|--------|--|---------|-----|-----|------|
| | | | min | typ | max | Uill |
| Collector Cutoff Current | ICBO | V _{CB} =15V, I _E =0A | | | 0.1 | μΑ |
| Emitter Cutoff Current | IEBO | V _{EB} =10V, I _C =0A | | | 0.1 | μΑ |

Marking: CJ Continued on next page.

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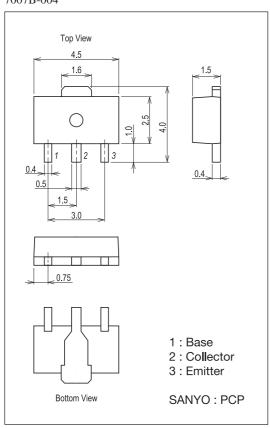
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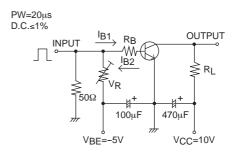
| Parameter | Symbol | Conditions | Ratings | | | Lloit |
|---|-----------------------|--|---------|------|------|-------|
| | | | min | typ | max | Unit |
| DC Current Gain | hFE1 | V _{CE} =2V, I _C =500mA | 800 | 1500 | 3200 | |
| | hFE2 | V _{CE} =2V, I _C =2A | 400 | | | |
| Gain-Bandwidth Product | fT | V _{CE} =10V, I _C =50mA | | 260 | | MHz |
| Output Capacitance | Cob | V _{CB} =10V, f=1MHz | | 28 | | pF |
| Collector-to-Emitter Saturation Voltage | V _{CE} (sat) | I _C =1A, I _B =20mA | | 0.11 | 0.5 | V |
| Base-to-Emitter Saturation Voltage | V _{BE} (sat) | I _C =1A, I _B =20mA | | 0.87 | 1.2 | V |
| Collector-to-Base Breakdown Voltage | V(BR)CBO | I _C =10μA, I _E =0A | 20 | | | V |
| Collector-to-Emitter Breakdown Voltage | V(BR)CEO | IC=1mA, RBE=∞ | 10 | | | V |
| Emitter-to-Base Breakdown Voltage | V(BR)EBO | I _E =10μA, I _C =0A | 15 | | | V |
| Turn-ON Time | ton | See specified Test Circuit. | | 0.13 | | μS |
| Storage Time | t _{stg} | See specified Test Circuit. | | 0.8 | | μS |
| Fall Time | tf | See specified Test Circuit. | | 0.1 | | μS |

Package Dimensions

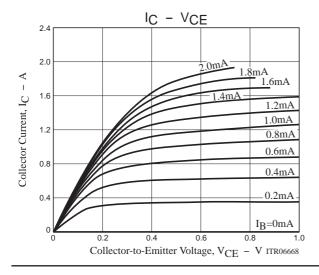
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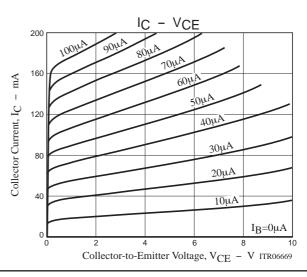


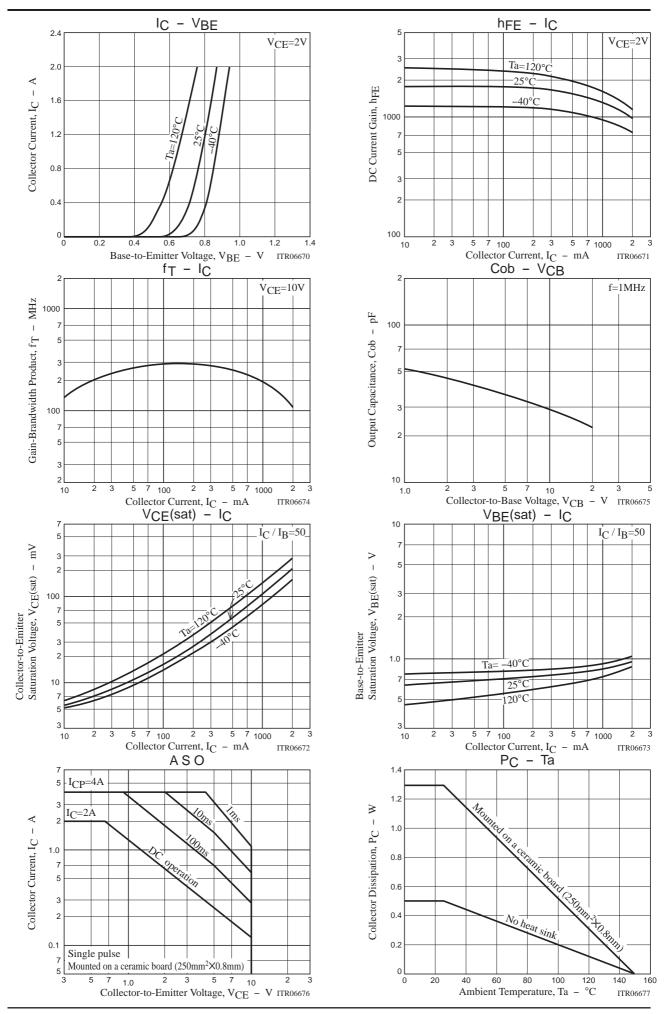
Switching Time Test Circuit



IC=100IB1=-100IB2=700mA







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